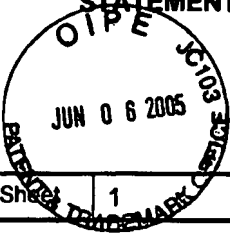
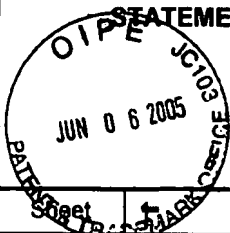


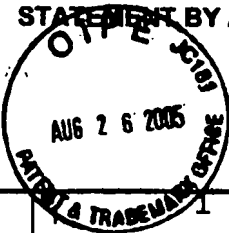
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			Filing Date		June 27, 2004	
			First Named Inventor		Gregory R. Hanson	
			Group Art Unit		2624- 2877	
			Examiner Name		Patrick Connolly	
Sheet	1	of	← 3	Attorney Docket		UBAT1490-1
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			Examiner Name	Patrick Connolly	
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				Examiner Name	Patrick Connolly		
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